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**Origin of reduced efficiency in high Ga concentration Cu(In,Ga)Se<sub>2</sub> solar cell** S.-H. WEI, B. HUANG, H. DENG, M.A. CONTRERAS, R. NOUFI, National Renewable Energy Laboratory, S. CHEN, L.W. WANG, Lawrence Berkeley National Laboratory — CuInSe<sub>2</sub> (CIS) is one of the most attractive thin-film materials for solar cells. It is well known that alloying Ga into CIS forming Cu(In,Ga)Se<sub>2</sub> (CIGS) alloy is crucial to achieve the high efficiency, but adding too much Ga will lead to a decline of the solar cell efficiency. The exact origin of this puzzling phenomenon is currently still under debate. Using first-principles method, we have systemically studied the structural and electronic properties of CIGS alloys. Our phase diagram calculations suggest that increasing growth temperature may not be a critical factor in enhancing the cell performance of CIGS under equilibrium growth condition. On the other hand, our defect calculations identify that high concentration of antisite defects  $M_{Cu}$  ( $M=In, Ga$ ) rather than anion defects are the key deep-trap centers in CIGS. The more the Ga concentration in CIGS, the more harmful the deep-trap is. Self-compensation in CIGS, which forms  $2V_{Cu}+M_{Cu}$  defect complexes, is found to be beneficial to quench the deep-trap levels induced by  $M_{Cu}$  in CIGS, especially at low Ga concentration. Unfortunately, the density of isolated  $M_{Cu}$  is quite high and cannot be largely converted into  $2V_{Cu}+M_{Cu}$  complexes under thermal equilibrium condition. Thus, nonequilibrium growth conditions or low growth temperature that can suppress the formation of the deep-trap centers  $M_{Cu}$  may be necessary for improving the efficiency of CIGS solar cells with high Ga concentrations.

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